

Trench Field-Stop Technology IGBT

Features

- 1200V, 15A
- Low Switching Losses
- Low $V_{CE(sat)}$ with Positive Temperature Coefficient
- Pb-free Lead Plating; RoHS Compliant

Applications

- Frequency Converters
- Uninterruptive Power Supply
- Air Conditioning
- Motor Drives

Die Description

	Wafer Diameter	8 inches
	Wafer Thickness	5 mils
	Die Size(including SL)	4142*3800 μm^2
	Scribe Line Width	80 μm
	Gross Die	1679
Metalization	Frontside	AlSiCu
	Backside	Al/Ti/NiV/Ag
Metal Thickness	Frontside	4 μm
	Backside	1.1 μm
Bonding Area	Gate	1081*602 μm^2
	Emitter	2316*1493 μm^2
Recommended Wire Bonding	Gate	Al/5mils*1
	Emitter	Al/15mils*1

Absolute Maximum Ratings¹ ($T_C=25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Value	Unit
V_{CES}	Collector-Emitter Voltage	1200	V
V_{GES}	Gate-Emitter Voltage	± 20	V
I_C	Continuous Collector Current ($T_C=25^\circ\text{C}$)	30	A
	Continuous Collector Current ($T_C=100^\circ\text{C}$)	15	A
I_{CM}	Pulsed Collector Current ²	45	A
t_{sc}	Short Circuit Withstand Time	10	μs
T_J	Operating Junction Temperature Range	-55 to 175	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$

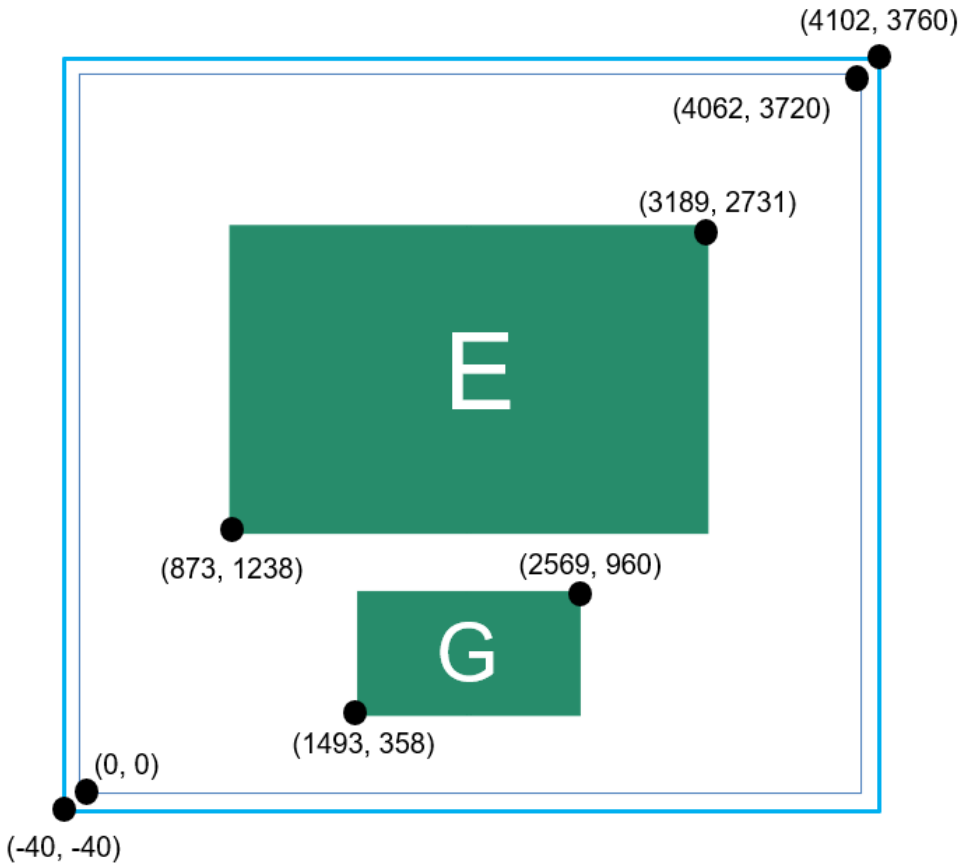
Electrical Characteristic¹ ($T_C=25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Values			Unit
			Min.	Typ.	Max.	
$B_{V_{CES}}$	Collector-Emitter Breakdown Voltage	$V_{GE}=0V, I_C=500\mu A$	1200	---	---	V
I_{CES}	Collector-Emitter Leakage Current	$V_{CE}=1200V, V_{GE}=0V$	---	---	1	mA
I_{GES}	Gate Leakage Current, Forward	$V_{GE}=20V, V_{CE}=0V$	---	---	400	nA
	Gate Leakage Current, Reverse	$V_{GE}=-20V, V_{CE}=0V$	---	---	-400	nA
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE}=V_{CE}, I_C=480\mu A$	5.2	5.8	6.4	V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$V_{GE}=15V, I_C=15A$	---	2.00	2.25	V
Q_G	Total Gate Charge	$V_{CC}=960V$ $V_{GE}=15V$ $I_C=15A$	---	68	---	nC
Q_{GE}	Gate-Emitter Charge		---	12.8	---	nC
Q_{GC}	Gate-Collector Charge		---	50.2	---	nC
$t_{d(on)}$	Turn-on Delay Time	$V_{CC}=600V$ $V_{GE}=\pm 15V$ $I_C=15A$ $R_G=39\Omega$ Inductive Load $T_C=25^\circ\text{C}$	---	36	---	ns
t_r	Turn-on Rise Time		---	28	---	ns
$t_{d(off)}$	Turn-off Delay Time		---	215	---	ns
t_f	Turn-off Fall Time		---	226	---	ns
E_{on}	Turn-on Switching Loss		---	1.62	---	mJ
E_{off}	Turn-off Switching Loss		---	1.11	---	mJ
E_{ts}	Total Switching Loss		---	2.73	---	mJ
C_{ies}	Input Capacitance	$V_{CE}=25V$ $V_{GE}=0V$ $f=1\text{MHz}$	---	903	---	pF
C_{oes}	Output Capacitance		---	94	---	pF
C_{res}	Reverse Transfer Capacitance		---	48	---	pF

Note 1 : Tested on package TO-247

2 : Repetitive Rating, Pulse width limited by maximum junction temperature

Chip Outline & Information:



Die Size:
 (including SL)
 $4142 * 3800 \mu\text{m}^2$

Gate Pad Size:
 $1076 * 602 \mu\text{m}^2$

Emitter Pad Size:
 $2316 * 1493 \mu\text{m}^2$

Scribe Line:
 $80 \mu\text{m}$

Revision History

Ver.	Date	Change Notice
1.0	2020/11/10	Released